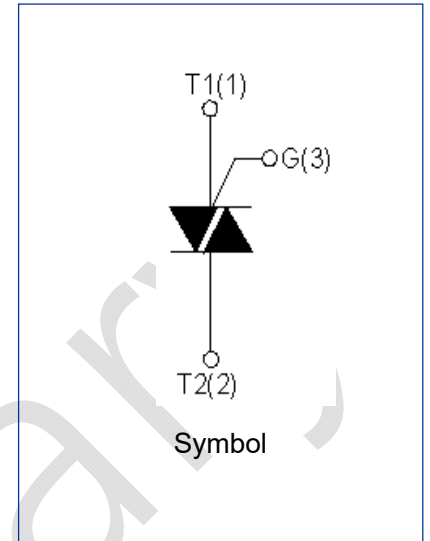


**JST41TW Series**
**41A TRIACs**
**DESCRIPTION**

JST41TW series triacs, with high ability to withstand the shock loading of large current, provide high dv/dt rate with strong resistance to electromagnetic interface. With high commutation performances, 3 quadrants products especially recommended for use on inductive load

**MAIN FEATURES**

Symbol	Value	Unit
$I_{T(RMS)}$	41	A
$V_{ISO}$	2500	V
$V_{DRM} / V_{RRM}$	600, 800, 1200, and 1600	V


**ABSOLUTE MAXIMUM RATING** (Rating at  $T_A=25^\circ\text{C}$  unless otherwise specified.)

Parameter		Symbol	Value	Unit
Storage temperature range		$T_{STG}$	-40-150	$^\circ\text{C}$
Operating junction temperature range		$T_J$	-40-125	$^\circ\text{C}$
Repetitive peak off-state voltage		$V_{DRM}$	600/800/1200/1600	V
Repetitive peak reverse voltage		$V_{RRM}$	600/800/1200/1600	V
Non repetitive surge peak off-state voltage		$V_{DSM}$	$V_{DRM} + 100$	V
Non repetitive peak reverse voltage		$V_{RSM}$	$V_{RRM} + 100$	V
RMS on-state current	TG-C ( $T_C=90^\circ\text{C}$ )	$I_{T(RMS)}$	41	A
Non repetitive surge peak on-state current	full cycle, $F=50\text{Hz}$	$I_{TSM}$	400	A
$I^2t$ value for fusing	$t_P=10\text{ms}$	$I^2t$	880	$\text{A}^2\text{s}$
Critical rate of rise of on-state current	$I_G=2 \times I_{GT}$	$di/dt$	50	$\text{A}/\mu\text{s}$
Peak gate current		$I_{GM}$	4	A
Average gate power dissipation		$P_{G(AV)}$	1	W
Peak gate power		$P_{GM}$	10	W
Insulation voltage	A.C, $F=50\text{Hz}$ , 1min	$V_{ISO}$	2500	V

**ELECTRICAL CHARACTERISTICS** (Rating at  $T_A=25^\circ\text{C}$  unless otherwise specified.)

**3 Quadrants**

Parameter	Test Condition	Symbol	Min.	Typ.	Max.	Unit	
Triggering gate current	$V_D=12\text{V}, R_L=33\Omega$	I - II - III	$I_{GT}$	-	-	50	mA
Triggering gate voltage		I - II - III	$V_{GT}$	-	-	1.3	V
Non triggering gate voltage	$V_D=V_{DRM}, T_J=125^\circ\text{C}$ $R_L=3.3\text{K}\Omega$	I - II - III	$V_{GD}$	0.2	-	-	V
Latching current	$I_G=1.2I_{GT}$	I - III	$I_L$	-	-	80	mA
		II		-	-	100	
Holding current	$I_T=100\text{mA}$		$I_H$	-	-	60	mA
Critical rate of rise of voltage	$V_D=2/3V_{DRM}, \text{Gate Open}, T_J=125^\circ\text{C}$		$dv/dt$	1000	-	-	$\text{V}/\mu\text{s}$
	Without snubber, $T_J=125^\circ\text{C}$		$(dv/dt)_c$	20	-	-	$\text{V}/\mu\text{s}$

**4 Quadrants**

Parameter	Test Condition	Symbol	Min.	Typ.	Max.	Unit	
Triggering gate current	$V_D=12\text{V}, R_L=33\Omega$	I - II - III	$I_{GT}$	-	-	50	mA
		IV		-	-	70	
Triggering gate voltage		All	$V_{GT}$	-	-	1.5	V
Non triggering gate voltage	$V_D=V_{DRM}, T_J=125^\circ\text{C}$ $R_L=3.3\text{K}\Omega$	All	$V_{GD}$	0.2	-	-	V
Latching current	$I_G=1.2I_{GT}$	I - III - IV	$I_L$	-	-	90	mA
		II		-	-	100	
Holding current	$I_T=100\text{mA}$		$I_H$	-	-	80	mA
Critical rate of rise of voltage	$V_D=2/3V_{DRM}, \text{Gate Open}, T_J=125^\circ\text{C}$		$dv/dt$	500	-	-	$\text{V}/\mu\text{s}$
	Without snubber, $T_J=125^\circ\text{C}$		$(dv/dt)_c$	30	-	-	$\text{V}/\mu\text{s}$

**STATIC CHARACTERISTICS**

Parameter	Test Condition	Symbol	Min.	Typ.	Max.	Unit
Peak on-state voltage	$I_{TM}=60A, t_p=380\mu s, T_J=25^\circ C$	$V_{TM}$	-	-	1.55	V
Threshold voltage	$T_J=125^\circ C$	$V_{TO}$	-	-	0.85	V
Dynamic resistance	$T_J=125^\circ C$	$R_d$	-	-	9	m $\Omega$
Repetitive peak off-state current	$V_D = V_{DRM}, T_J=25^\circ C$	$I_{DRM}$	-	-	10	$\mu A$
Repetitive peak reverse current	$V_R = V_{RRM}, T_J=125^\circ C$	$I_{RRM}$	-	-	5	mA

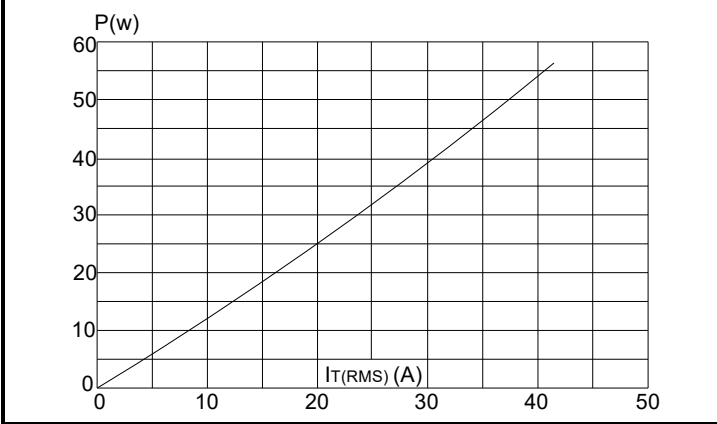
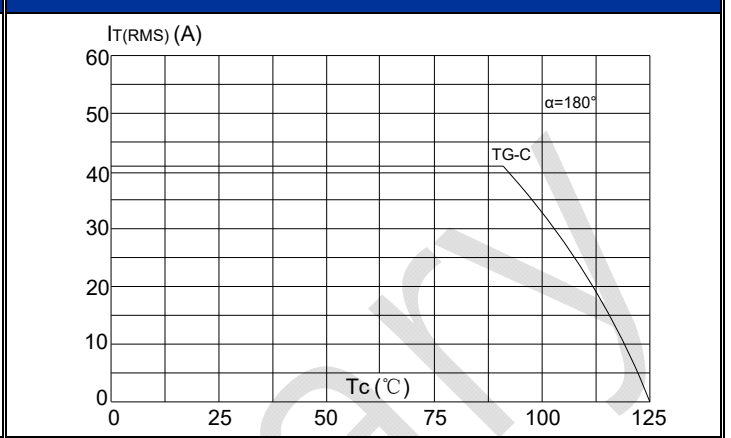
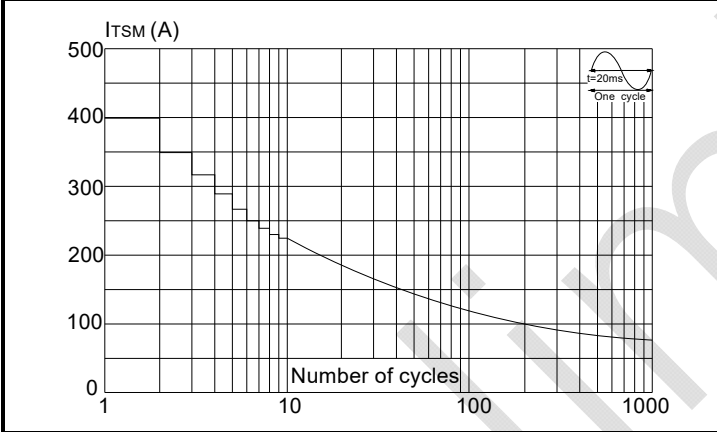
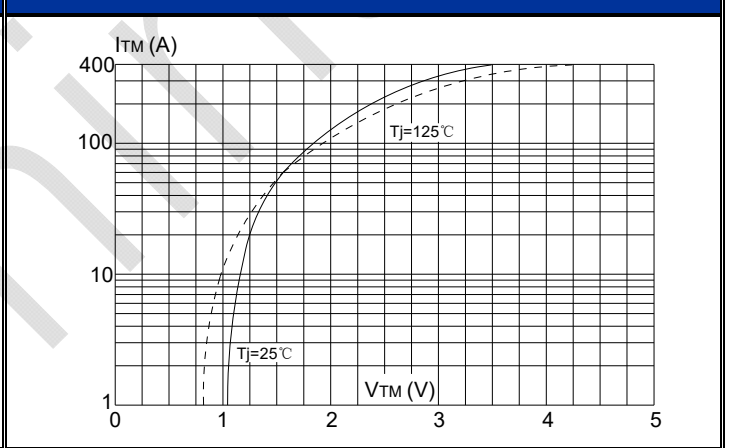
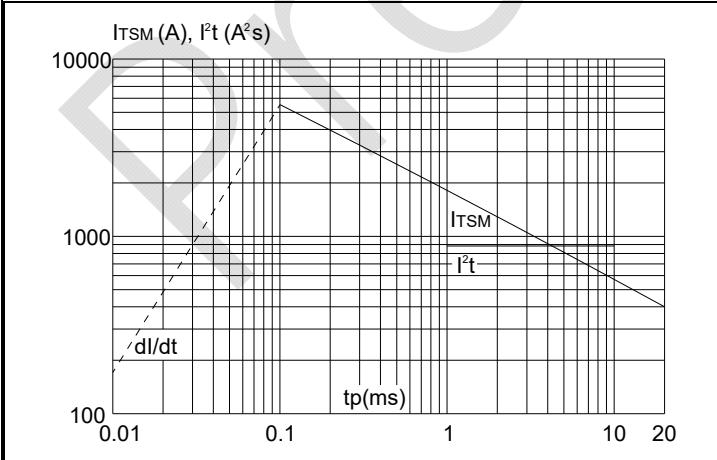
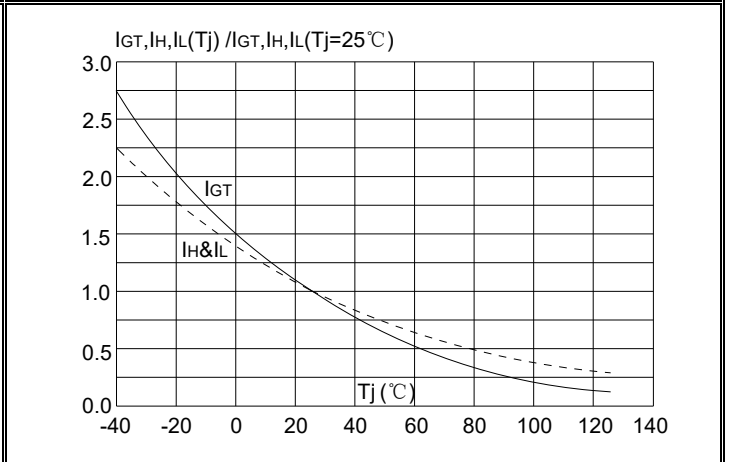
**THERMAL RESISTANCES**

Symbol	Parameter	Min.	Typ.	Max.	Unit
$R_{th(j-c)}$	Thermal resistance from junction to case	-	1.45	-	$^\circ C/W$
	Mounting torque(M4) Recommended value 1.0~1.4	-	-	1.5	N·m

**PART NUMBER INFORMATION**

JieJie Microelectronics Co., Ltd. JieJie Semiconductor Co., Ltd.	<b>J</b> Triacs $I_{T(RMS)}:41A$	<b>ST</b>	<b>41</b> $T: TG-C$	<b>T</b>	<b>W</b> T1, T2 terminals: $\phi 4mm$	<b>-600</b>	<b>BW</b> BW: $I_{GT1-3} \leq 50mA$ B: $I_{GT1-3} \leq 50mA, I_{GT4} \leq 70mA$ 600: $V_{DRM}/V_{RRM} \geq 600V$ 800: $V_{DRM}/V_{RRM} \geq 800V$ 1200: $V_{DRM}/V_{RRM} \geq 1200V$ 1600: $V_{DRM}/V_{RRM} \geq 1600V$
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**CHARACTERISTICS CURVE**
**FIG. 1: Maximum power dissipation versus RMS on-state current**

**FIG. 2: RMS on-state current versus case temperature**

**FIG. 3: Surge peak on-state current versus number of cycles**

**FIG. 4: On-state characteristics (maximum values)**

**FIG. 5: Non-repetitive surge peak on-state current for a sinusoidal pulse with width  $t_p < 20\text{ms}$ , and corresponding value of  $I^2t$  ( $di/dt < 50\text{A}/\mu\text{s}$ )**

**FIG. 6: Relative variations of gate trigger current, holding current and latching current versus junction temperature**




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Preliminary